


<b>Search Notes</b> 	<b>Application/Control No.</b> 10525800	<b>Applicant(s)/Patent Under Reexamination</b> TSUTSUI ET AL.
	<b>Examiner</b> Ana L. Woodward	<b>Art Unit</b> 1796

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
Machine english translation of JP 2000-44683	3/25/08	aw
Inventor name search	"	"

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